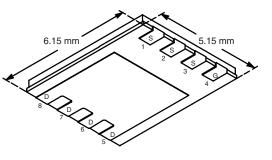


COMPLIANT

# N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
30	0.006 at V <sub>GS</sub> = 10 V	35	12 nC			
	0.008 at V <sub>GS</sub> = 4.5 V	35	12110			



PowerPAK SO-8

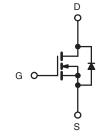
Bottom View

**FEATURES** 

- Halogen-free
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested

#### **APPLICATIONS**

- Synchronous Rectification
- DC/DC Point-of-Load
- Server



Ordering Information: SiR402DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATIN</b>	I <b>GS</b> T <sub>A</sub> = 25 °C,	unless othe	rwise noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		35 <sup>a</sup>		
Continuous Drain Current (T 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	35 <sup>a</sup>		
Continuous Drain Current ( $T_J = 150 \ ^{\circ}C$ )	T <sub>A</sub> = 25 °C		20.7 <sup>b, c</sup>	•	
	T <sub>A</sub> = 70 °C		16.6 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	70		
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	35		
Avalanche Energy		E <sub>AS</sub>	61	mJ	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		30	Α	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	3.5 <sup>b, c</sup>	A	
	T <sub>C</sub> = 25 °C		36		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C		23	w	
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	4.2 <sup>b, c</sup>	vv	
	T <sub>A</sub> = 70 °C		2.7 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>			260		

#### THERMAL RESISTANCE BATINGS

Parameter		Symbol Typical		Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	25	30	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	2.9	3.5			

Notes:

a. Based on  $T_C = 25$  °C. Package limited. b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed www.DataScopper/(not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 70 °C/W.

# SiR402DP



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		24		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	i <sub>D</sub> = 250 μA		- 6			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	v l		1		
		$V_{DS}$ = 30 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C			5	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	50			Α	
	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.0048	0.006	1	
Drain-Source On-State Resistance <sup>a</sup>		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 17.5 A		0.0064	0.008	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A		82		S	
Dynamic <sup>b</sup>					<u> </u>	1	
Input Capacitance	C <sub>iss</sub>			1700			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		350		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			140			
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		28	42		
Total Gate Charge	Qg			12	21	nC	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 20 A		5.4			
Gate-Drain Charge	Q <sub>gd</sub>			4.6			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		1.2	2.4	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			25	40	- ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, \text{ R}_{\text{I}} = 1.5 \Omega$		20	30		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10$ Å, $V_{GEN} = 4.5$ V, $R_g = 1$ $\Omega$		25	40		
Fall Time	t <sub>f</sub>	-		15	25		
Turn-On Delay Time	t <sub>d(on)</sub>			12	20		
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, \text{ R}_{\text{I}} = 1.5 \Omega$		10	15		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		25	40		
Fall Time	t <sub>f</sub>	-		10	15		
Drain-Source Body Diode Characteristi	cs					1	
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			30		
Pulse Diode Forward Current	I <sub>SM</sub>			1	70	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 10 A, V <sub>GS</sub> = 0 V		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			25	50	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			17	35	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{T}_J = 25 ^\circ\text{C}$		13		ns	
Reverse Recovery Rise Time	t <sub>b</sub>	-		12			

Notes:

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

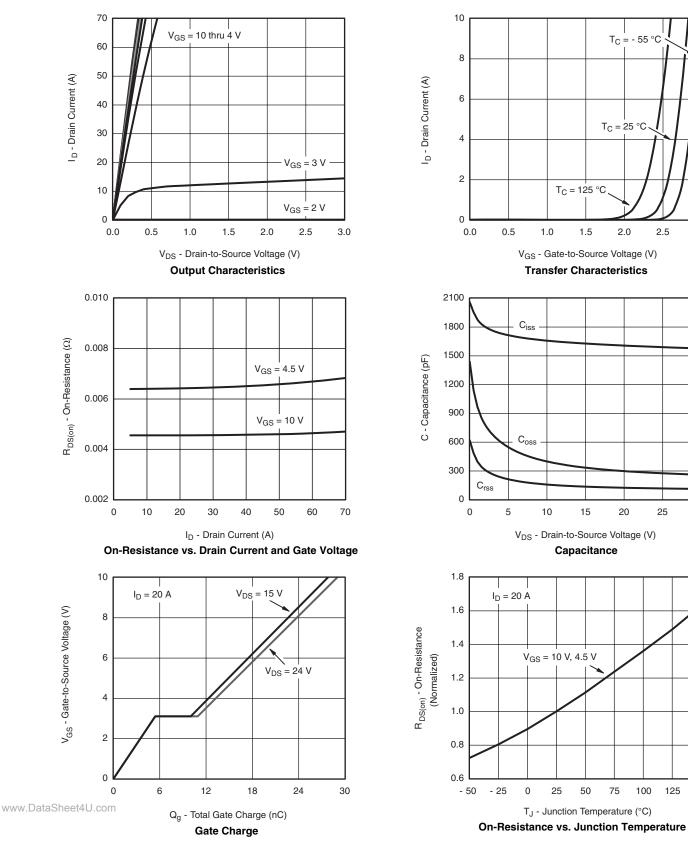


# Vishay Siliconix

3.0

30

### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



150

# SiR402DP

10

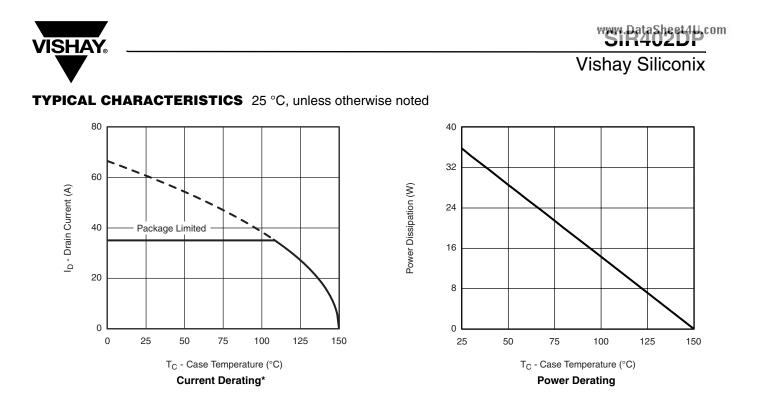
600

## Vishay Siliconix

#### 0.015 100 I<sub>D</sub> = 20 A 0.012 $R_{DS(on)}$ - On-Resistance ( $\Omega$ ) I<sub>S</sub> - Source Current (A) 0.009 $T_J = 25 \ ^{\circ}C$ . T<sub>J</sub> = 150 °C $T_J = 125 \ ^\circ C$ 10 0.006 $T_J = 25 \ ^\circ C$ 0.003 1 0.000 0.0 0.2 0.4 1.2 0 2 4 8 0.6 0.8 1.0 6 V<sub>SD</sub> - Source-to-Drain Voltage (V) V<sub>GS</sub> - Gate-to-Source Voltage (V) Source-Drain Diode Forward Voltage **On-Resistance vs. Gate-to-Source Voltage** 2.4 50 2.2 40 2.0 $I_D = 250 \ \mu A$ V<sub>GS(th)</sub> (V) Power (W) 30 1.8 1.6 20 1.4 10 1.2 1.0 0 - 25 50 100 - 50 0 25 75 125 150 0.001 0.01 0.1 1 10 100 T<sub>J</sub> - Temperature (°C) Time (s) **Threshold Voltage** Single Pulse Power (Junction-to-Ambient) 100 Limited by R<sub>DS(or</sub> 100 µs 10 I<sub>D</sub> - Drain Current (A) 1 ms 10 m 100 ms -1 s 10 s 0.1 ⊨⊨ DC T<sub>A</sub> = 25 °C Single Pulse **BVDSS** Limited 1 1 1 1 0.01 0.1 10 100 1 V<sub>DS</sub> - Drain-to-Source Voltage (V) \* $V_{GS}$ > minimum $V_{GS}$ at which $R_{DS(on)}$ is specified

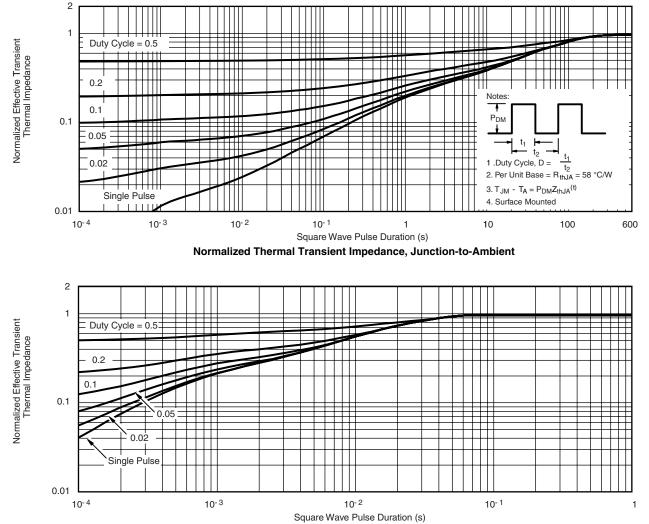
Safe Operating Area, Junction-to-Ambient

#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Case

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Vishay

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